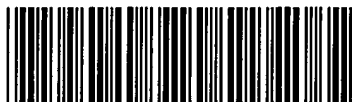


Search Notes

Application/Control No.

10/675,013

Examiner

TAN X. DINH

Applicant(s)/Patent under
Reexamination

URUSHIHARA ET AL.

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
720	626 619		
720	645		
720	624		
720	623		
720	620		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference Search History Printout)		2/15/2007	T.D

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (see search history printout)	2/15/2007	T.D